

# Towards Effective Adaptive Random Testing for Higher-Dimensional Input Domains

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## ABSTRACT

Adaptive Random Testing subsumes a class of algorithms that detect the first failure with less test cases than Random Testing. The present paper shows that a “reference method” in the field of Adaptive Random Testing is not effective for higher dimensional input domains and clustered failure-causing inputs. The reason for this behavior is explained, and a modified method is proposed and analyzed.

## Categories and Subject Descriptors

D.2.5 [Software Engineering]: Testing and Debugging—*Testing tools*; G.3 [Probability and Statistics]: Reliability and life testing

## General Terms

Algorithms, Reliability, Verification

## Keywords

Adaptive Random Testing, Random Testing, Test case selection

## 1. INTRODUCTION

Random Testing (RT) [5], i.e. the random generation of test inputs, is a promising approach to the automation of test case generation since it is unbiased and easy to implement. Chan et al. [1] observed that failure-causing inputs form clusters within the input domain. They coarsely classified these clusters, called failure patterns, into block, strip, and point type. Based thereon, Chen et al. [4] deduced that wide-spread test cases have a better chance to detect a failure with less test cases than Random Testing and introduced Adaptive Random Testing (ART) based on this notion.

Chen et al. [4] introduced the *F-measure* which denotes the (random) number of test cases necessary to detect the first failure. The F-measure has been used to compare all ART algorithms so far. The first ART method was Distance-Based ART (D-ART) [3, 4]. This method is considered the best one (besides the similar RRT) in the ART community due to its low F-measure.

Chen et al. [2] presented simulation results for D-ART with block failure pattern and one-, two- resp. three-dimensional input domains. These results show an interesting be-

havior: The F-measure of D-ART gets worse the higher the dimension.

The present paper first investigates the finding by Chen et al. [2] and systematically analyzes D-ART for dimensions  $d = 2, 3, \dots, 6$  with a simulation study. The not so good F-measure of D-ART in higher dimensions is explained and an improved algorithm is proposed.

After the introduction of preliminaries in Section 2, the D-ART method is explained and discussed in Section 3. An improved algorithm is presented in Section 4 accompanied by simulation results. Section 5 concludes this paper.

## 2. PRELIMINARIES

An input is said to be *failure-causing* if the program execution with this input leads to a failure. The percentage of failure-causing inputs within the input domain is said the *failure rate*  $\theta$ . The theoretical mean F-measure of Random Testing is simply  $1/\theta$ . The *relative mean F-measure* of a method is its mean F-measure related to the theoretical mean F-measure of RT.

## 3. DISTANCE-BASED ART

Distance-Based ART (D-ART) [3, 4] with fixed sized candidate set randomly selects the first test case. Thereafter, a set of test case candidates—each one randomly chosen—of size  $k$  is computed in each iteration. The candidate with the greatest minimal distance to all previously executed test cases is chosen as the next test case. In the following iteration, a new candidate set is chosen and the procedure is repeated until a failure is detected (or the resources for testing are exhausted). The size  $k = 10$  of the candidate set has been recommended.

The relative mean F-measure of D-ART has been determined through simulation for input domains of various dimensions ( $d$ ) and several failure rates ( $\theta$ ) each with 5000 randomly generated block failure patterns (hyper cubes with random location within the input domain). Table 1 shows the results. Each relative mean F-measure value is accompanied by its accuracy on confidence level 99% determined by the Central Limit Theorem. The simulation confirms the results by Chen et al. [2] and shows that D-ART is less effective the higher dimension and the higher the failure rate. For higher dimensions and higher failure rates, the relative mean F-measure of D-ART is even greater than 1, which means that D-ART is less effective than RT in these cases.

In order to analyze the reason for the low effectiveness of D-ART, Table 2 shows the width of a cubic block failure

**Table 1: Relative mean F-measure of D-ART for the block failure pattern**

	Failure Rate $\theta$				
	0.01	0.005	0.002	0.001	0.0005
$d = 2$	0.680 ( $\pm 0.018$ )	0.645 ( $\pm 0.017$ )	0.639 ( $\pm 0.018$ )	0.645 ( $\pm 0.018$ )	0.638 ( $\pm 0.018$ )
$d = 3$	0.840 ( $\pm 0.024$ )	0.805 ( $\pm 0.023$ )	0.768 ( $\pm 0.022$ )	0.751 ( $\pm 0.022$ )	0.752 ( $\pm 0.023$ )
$d = 4$	1.070 ( $\pm 0.032$ )	1.000 ( $\pm 0.030$ )	0.928 ( $\pm 0.028$ )	0.893 ( $\pm 0.028$ )	0.890 ( $\pm 0.028$ )
$d = 5$	1.315 ( $\pm 0.039$ )	1.238 ( $\pm 0.038$ )	1.150 ( $\pm 0.036$ )	1.104 ( $\pm 0.034$ )	1.041 ( $\pm 0.033$ )
$d = 6$	1.617 ( $\pm 0.049$ )	1.537 ( $\pm 0.047$ )	1.409 ( $\pm 0.044$ )	1.340 ( $\pm 0.042$ )	1.251 ( $\pm 0.040$ )

**Table 2: Relative width of a  $d$ -dimensional hyper cube for failure rate  $\theta = 0.01$**

$d$	2	3	4	5	6	7	8
$w$	0.100	0.215	0.316	0.398	0.464	0.518	0.562

pattern related to the width of the ( $d$ -dimensional) cubic input domain for failure rate  $\theta = 0.01$ . The relative width  $w = \sqrt[d]{\theta}$  increases with the dimension  $d$ . For dimensions  $d \geq 7$  it even contains the mid point of the input domain with probability one.

D-ART is designed to widely spread the test cases over the whole input domain. Therefore, this method searches in a by far too large domain. E.g. for  $d \geq 7$ , it is obviously sufficient to have exactly one test case located at the center of the input domain.

#### 4. ART WITH INCREASING DOMAIN

For the reasons mentioned, we should adapt D-ART to select the test cases from a sub-domain centered around the middle of the input domain. This sub-domain has to be enlarged as the algorithm proceeds to approach the whole input domain. More formally, we assume w.l.g. that the input domain is the hyper cuboid  $I := \{(0, \dots, 0)(w_1, \dots, w_d)\}$ .<sup>1</sup> Then, D-ART with Increasing Domain (ID-D-ART) selects the  $k$  th test case (and all candidates used for this selection) from the hyper cuboid

$$\begin{aligned} I_k &:= \{(r_d(k)w_1, \dots, r_d(k)w_d) \\ &\quad ((1 - r_d(k))w_1, \dots, (1 - r_d(k))w_d)\}, \end{aligned}$$

instead of the whole input domain (as D-ART does), where the restriction function  $r_d(k)$  is defined as

$$r_d(k) = f_0 / \sqrt[d]{k},$$

with  $k \geq 1$  and  $f_0 \in [0, \frac{1}{2}]$ . The series  $I_1, I_2, \dots$  is monotonically increasing and approaching  $I$ , with  $I_1 \subset I_2 \subset \dots \subset I$ .

To evaluate the effectiveness of ID-D-ART, a simulation study analogous to the previous one (cf. Table 1) has been conducted with  $f_0 = 0.49$  (as determined through a separate

<sup>1</sup>We denote a hyper cuboid  $\{p_{min}p_{max}\}$  by its points with minimal ( $p_{min}$ ) and maximal ( $p_{max}$ ) coordinates.

**Table 3: Relative mean F-measure of ID-D-ART for the block failure pattern**

	Failure Rate $\theta$				
	0.01	0.005	0.002	0.001	0.0005
$d = 2$	0.523 ( $\pm 0.015$ )	0.563 ( $\pm 0.016$ )	0.579 ( $\pm 0.017$ )	0.599 ( $\pm 0.017$ )	0.591 ( $\pm 0.017$ )
$d = 3$	0.405 ( $\pm 0.014$ )	0.453 ( $\pm 0.015$ )	0.507 ( $\pm 0.017$ )	0.537 ( $\pm 0.017$ )	0.572 ( $\pm 0.018$ )
$d = 4$	0.269 ( $\pm 0.010$ )	0.315 ( $\pm 0.012$ )	0.366 ( $\pm 0.014$ )	0.424 ( $\pm 0.015$ )	0.467 ( $\pm 0.017$ )
$d = 5$	0.149 ( $\pm 0.007$ )	0.190 ( $\pm 0.008$ )	0.252 ( $\pm 0.010$ )	0.291 ( $\pm 0.012$ )	0.337 ( $\pm 0.013$ )
$d = 6$	0.058 ( $\pm 0.004$ )	0.098 ( $\pm 0.005$ )	0.144 ( $\pm 0.007$ )	0.183 ( $\pm 0.009$ )	0.217 ( $\pm 0.010$ )

simulation study) and  $k = 10$ . Table 3 shows the results of this study. The F-measure of ID-D-ART is much better than that of D-ART and always below 1 which means that ID-D-ART is always more effective than RT. Furthermore, the effectiveness of ID-D-ART improves for higher-dimensional input domains as opposed to D-ART.

#### 5. CONCLUSION

In the present paper it has been shown that the “reference method” D-ART, is not so effective for clustered failure-causing inputs (more precisely, the block failure pattern) and higher-dimensional input domains. Therefore, its practical use is limited. However, an improved version of the algorithm has been proposed that selects the test cases from a sub-domain of the input domain. This sub-domain increases and approaches the whole input domain as the algorithm proceeds. The proposed algorithms is more effective than D-ART and also RT for the block failure pattern—even for higher-dimensional input domains.

Due to the similarity of D-ART and RRT, the proposed approach can also be applied to RRT. First simulations have shown that the results for RRT are similar.

Furthermore, a detailed investigation on the restriction function  $r_d(\cdot)$  as well as on the factor  $f_0$  should be made.

#### 6. REFERENCES

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